



Attorney Docket No.: 0073US/PCT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of MALEK et al.

Serial No.: To Be Assigned

Examiner: To Be Assigned

Confirmation No.: To Be Assigned

Art Unit: To Be Assigned

Filed: Herewith

Title: Measuring Cell for Ion Cyclotron Resonance Spectrometer

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

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Sir:

The information listed on the attached PTO/SB/08 form may be material to the examination of the above-identified application. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or publications can be provided upon request. The Examiner is respectfully requested to make this information of official record in the application.

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Dated: 21 March 2004

Respectfully submitted,

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PTO/SB/08b (07-05)

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					Application Number	To Be Assigned 2020		
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (Use as many sheets as necessary)				Filing Date	Herewith		
					First Named Inventor	Robert Malek To Be Assigned		
					Art Unit Examiner Name			
						To Be Assigned		
	Sheet	1	of	1	Attorney Docket Number	0073US/PCT		

NON PATENT LITERATURE DOCUMENTS								
Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²						
C1	NIKOLAEV ET AL., "Analysis of Harmonics for an Elongated FTMS Cell with Multiple Electrode Detection J. of Mass Spectrom and Ion Process, Elsevier Scientific Publ. Co. (Amsterdam, NL), p. 215-232, (Decemb 1996).							
C2	BEU ET AL., "Open Trapped Ion Cell Geometries for Fourier Transform Ion Cyclotron Resonance Mass Spectrometry," Int'l J. of Mass Spectrom. and Ion Processes, Elsevier Scientific Publ. Co. (Amsterdam, NL), p. 215-230, (January 12, 1992).	*********						
С3	SHENHENG ET AL., "Ion Traps for Fourier Transform Ion Cyclotron Resonance Mass Spectrometry: Principles an Design of Geometric and Electric Configurations," Int'l J. Mass Spectrom and Ion Processes, Elsevier Scientific Pub Co. (Amsterdam, NL), p. 261-296, (August 31, 1995).	d						
C4	VARTANIAN ET AL., "High Performance Fourier Transform Ion Cyclotron Resonance Mass Spectrometry via a Single Trap Electrode," J. Am. Soc. Mass Spectrom., Elsevier Science Inc. (U.S.), Vol. 6 (No. 9), p. 812-821, (September 1, 1995).							
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	C1 C2 C3	Cite No.1  Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.  NIKOLAEV ET AL., "Analysis of Harmonics for an Elongated FTMS Cell with Multiple Electrode Detection," In J. of Mass Spectrom and Ion Process, Elsevier Scientific Publ. Co. (Amsterdam, NL), p. 215-232, (December 20, 1996).  BEU ET AL., "Open Trapped Ion Cell Geometries for Fourier Transform Ion Cyclotron Resonance Mass Spectrometry," Int'l J. of Mass Spectrom. and Ion Processes, Elsevier Scientific Publ. Co. (Amsterdam, NL), p. 215-230, (January 12, 1992).  SHENHENG ET AL., "Ion Traps for Fourier Transform Ion Cyclotron Resonance Mass Spectrometry: Principles an Design of Geometric and Electric Configurations," Int'l J. Mass Spectrom and Ion Processes, Elsevier Scientific Publ. Co. (Amsterdam, NL), p. 261-296, (August 31, 1995).  VARTANIAN ET AL., "High Performance Fourier Transform Ion Cyclotron Resonance Mass Spectrometry via a Single Trap Electrode," J. Am. Soc. Mass Spectrom., Elsevier Science Inc. (U.S.), Vol. 6 (No. 9), p. 812-821,						

Examiner	Date	
Signature	Considered	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.